

Search Notes

Application/Control No.

10/701,471

Examiner

Roberto Velez

Applicant(s)/Patent under
Reexamination

INOUE, HIROHITO

Art Unit

2829

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search:(US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB) PLUS Search and Text Search (See Search History)	9/5/2006	RV